

**Search Notes**

Application/Control No.

10/015,848

Examiner

Jason M. Perilla

Applicant(s)/Patent under  
Reexamination

PAYNE ET AL.

Art Unit

2611

**SEARCHED**

Class	Subclass	Date	Examiner
375	346	8/25/2005	JP
	350	8/25/2005	JP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East EPO/JPO USPAT/USPGPUB	5/25/06	JP
Inventor Name Search East/EDAN	8/25/2005	JP